### **DESCRIPTION**

The AM6003 is available in SOT-23 Package

BVDSS	RDSON	ID
60V	78mΩ	3A

## **FEATURE**

- Super Low Gate Charge
- $R_{DS(ON)} = 78 \text{m}\Omega(\text{Typ.}) @V_{GS} = 10 \text{V}$
- Excellent CdV/dt effect decline
- Advanced high cell density Trench technology

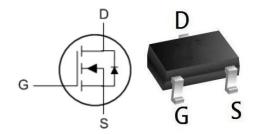
### **APPLICATION**

Small Power Switching and Load Switching applications

### **ORDERING INFORMATION**

Package Type	Part Number		
SOT-23	E3	AM6003E3R	
SPQ: 3,000pcs/Reel	E3	AM6003E3VR	
Note	V: Halogen free Package		
Note	R: Tape & Reel		
AiT provides all RoHS products			

## **PIN DESCRIPTION**



**SOT-23** 

Pin#	Symbol	Description
1	G	Gate
2	S	Source
3	D	Drain

# **ABSOLUTE MAXIMUM RATINGS**

T<sub>A</sub> = 25°C, unless otherwise specified.

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V <sub>DS</sub>	60	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current, V <sub>GS</sub> @ 10V (1)	I <sub>D</sub> @T <sub>A</sub> =25°C	3.0	Α
Continuous Drain Current, V <sub>GS</sub> @ 10V (1)	I <sub>D</sub> @T <sub>A</sub> =70°C	1.8	Α
Pulsed Drain Current (2)	Ірм	9.2	Α
Total Power Dissipation (3)	P <sub>D</sub> @T <sub>A</sub> =25°C	1	W
Storage Temperature Range	T <sub>STG</sub>	-55 to 150	℃
Operating Junction Temperature Range	TJ	-55 to 150	°C
Thermal Resistance Junction-Ambient (1)	Б	125	°0001
Thermal Resistance Junction-Case (1)	Reja	80	°C/W

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

- (1) The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- (2) The data tested by pulsed , pulse width  $\,\leqq\,$  300us , duty cycle  $\,\leqq\,$  2%
- (3) The power dissipation is limited by 150°C junction temperature.

# **ELECTRICAL CHARACTERISTICS**

T<sub>A</sub> = 25°C, unless otherwise specified.

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	60	-	-	V	
BVDSS Temperature Coefficient	△BV <sub>DSS</sub> /△	Reference to 25°C , I <sub>D</sub> =1mA	-	0.054	-	V/°C	
Static Drain-Source On-Resistance (2)	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =2A	-	78	105	mΩ	
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =1A	-	85	110		
Gate Threshold Voltage	V <sub>GS (th)</sub>	\/ -\/   -050A	1.2	-	2.5	V	
V <sub>GS</sub> (th) Temperature Coefficient	△V <sub>GS (th)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	-	-4.96	-	mV/°C	
Drain-Source Leakage Current		V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C	-	-	1		
	I <sub>DSS</sub>	V <sub>DS</sub> =48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C	-	-	5	uA	
Gate-Source Leakage Current	Igss	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	-	-	±100	nA	
Forward Transconductance	gfs	V <sub>DS</sub> =5V, I <sub>D</sub> =2A	-	13	-	S	
Total Gate Charge (4.5V)	Qg		-	5	7.0	nC	
Gate-Source Charge	Qgs	V <sub>DS</sub> =48V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =2A	-	1.68	2.4		
Gate-Drain Charge	$Q_{gd}$		-	1.9	2.7		
Turn-On Delay Time	T <sub>d(on)</sub>		-	1.6	3.2		
Rise Time	Tr	V <sub>DD</sub> =30V , V <sub>GS</sub> =10V ,	-	7.2	13	ns	
Turn-Off Delay Time	T <sub>d(off)</sub>	R <sub>G</sub> =3.3Ω, I <sub>D</sub> =2A	-	25	50		
Fall Time	T <sub>f</sub>		-	14.4	28.8		
Input Capacitance	Ciss		-	511	715		
Output Capacitance	Coss	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz	-	38	53	pF	
Reverse Transfer Capacitance	Crss		-	25	35		
Diode Characteristics							
Continuous Source Current (1)(4)	Is	V V 0V 5 0	-	-	2.3	Α	
Pulsed Source Current (2)(4)	Іѕм	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current	-	-	9.2	Α	
Diode Forward Voltage (2)	V <sub>SD</sub>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C	-	-	1.2	V	
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =2A , dI/dt=100A/μs ,	-	9.7	-	nS	
Reverse Recovery Charge	Qrr	T <sub>J</sub> =25°C	-	5.8	-	nC	

<sup>(1)</sup> The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

<sup>(2)</sup> The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

<sup>(4)</sup> The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.

### TYPICAL PERFORMANCE CHARACTERISTICS

Fig 1. Typical Output Characteristics

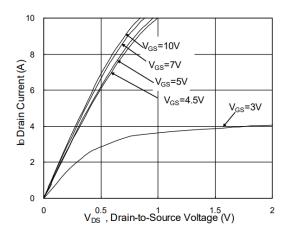


Fig 3. Forward Characteristics of Reverse

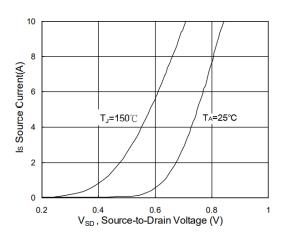


Fig 5. Normalized V<sub>GS</sub> (th) vs T<sub>J</sub>

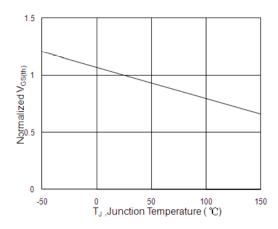


Fig 2. On-Resistance vs Gate-Source

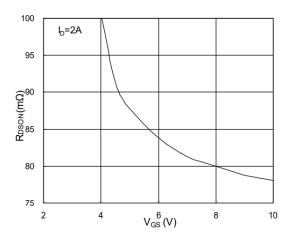


Fig 4. Gate-Charge Characteristics

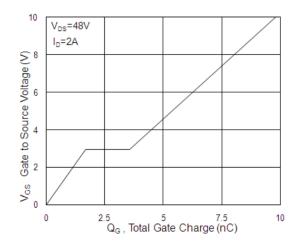


Fig 6. Normalized RDSON vs TJ

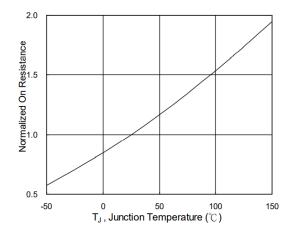


Fig 7. Capacitance

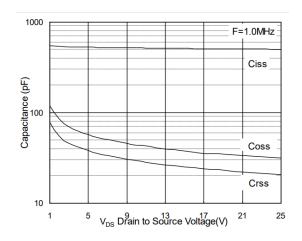


Fig 8. Safe Operating Area

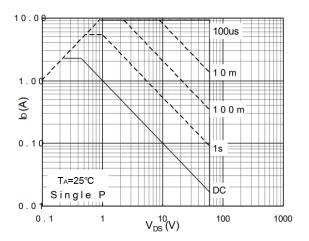


Fig 9. Maximum Safe Operation Area

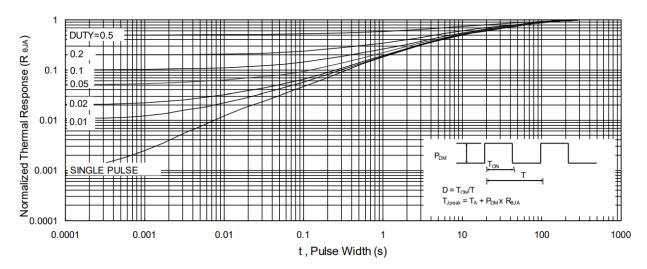


Fig 10. Switching Time Waveform

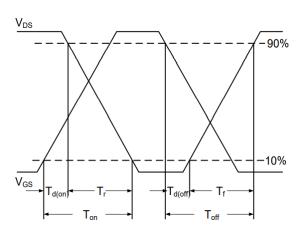
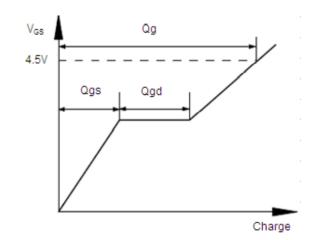
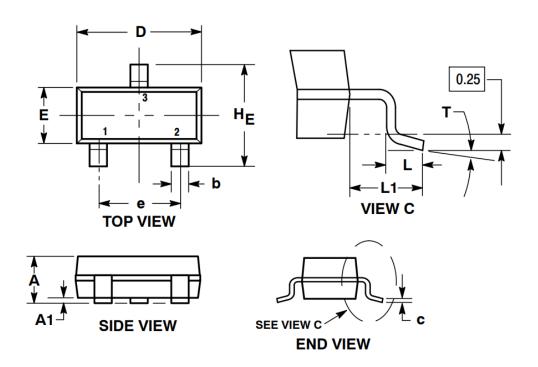


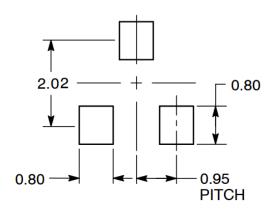
Fig 11. Gate Charge Waveform



## **PACKAGE INFORMATION**

Dimension in SOT-23 (Unit: mm)





RECOMMENDED SOLDERING FOOTPRINT

Symbol	Min	Max		
Α	0.90	1.15		
A1	0.00	0.10		
b	0.30	0.50		
С	0.08	0.15		
D	2.80	3.00		
Е	1.20	1.40		
е	1.80	2.00		
L	0.30	0.50		
L1	0.55 REF			
HE	2.25	2.55		
θ	0 °	8 °		

AM6003 MOSFET 60V, 3A N-CH MOSFET

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